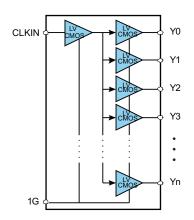


## 3.3 V and 2.5 V LVCMOS High-Performance Clock Buffer Family

Check for Samples: CDCLVC11xx

#### **FEATURES**

- High-Performance 1:2, 1:3, 1:4, 1:6, 1:8, 1:10,
   1:12 LVCMOS Clock Buffer Family
- Very Low Pin-to-Pin Skew < 50 ps
- Very Low Additive Jitter < 100 fs
- Supply Voltage: 3.3 V or 2.5 V
- f<sub>max</sub> = 250 MHz for 3.3 V
   f<sub>max</sub> = 180 MHz for 2.5 V



- Operating Temperature Range: –40°C to 85°C
- Available in 8-, 14-, 16-, 20-, 24-Pin TSSOP Package (all pin compatible)

#### **APPLICATIONS**

 General Purpose Communication, Industrial and Consumer Applications

CLKIN	1			24	Y1
1G	2	CDCLVC	1102	23	Υ3
Y0	3	CDCLVC	1103	22	VDD
GND	4	CDCLVC	1104	21	Y2
VDD	5			20	GND
Y4	6	CDCLVC	1106	19	Y5
GND	7	CDCLVC	1106	18	VDD
Y6	8	CDCLVC	1108	17	Υ7
VDD	9			16	Y8
Y9	10	CDCLVC	1110	15	GND
GND	11			14	Y10
Y11	12	CDCLVC	1112	13	VDD

#### **DESCRIPTION**

The CDCLVC11xx is a modular, high-performance, low-skew, general purpose clock buffer family from Texas Instruments.

The whole family is designed with a modular approach in mind. It is intended to round up TI's series of LVCMOS clock generators.

There are 7 different fan-out variations, 1:2 to 1:12, available. All of the devices are pin compatible to each other for easy handling.

All family members share the same high performing characteristics like low additive jitter, low skew, and wide operating temperature range.

The CDCLVC11xx supports an asynchronous output enable control (1G) which switches the outputs into a low state when 1G is low. Also, versions with synchronized enable control for glitch free switching and three-state outputs are planned in future device options.

The CDCLVC11xx operate in a 2.5 V and 3.3 V environment and are characterized for operation from -40°C to 85°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

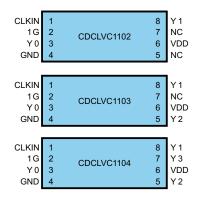


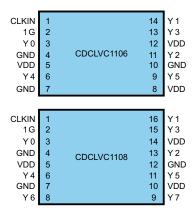
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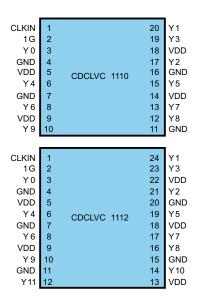


These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## **PACKAGE OPTIONS**







#### **PIN FUNCTIONS**

DEVICES	DEVICES LVCMOS CLOCK INPUT		LVCMOS CLOCK OUTPUT	SUPPLY VOLTAGE	GROUND
	CLKIN	1G	Y0, Y1, Y11	$V_{DD}$	GND
CDCLVC1102	1	2	3, 8	6	4
CDCLVC1103	1	2	3, 8, 5	6	4
CDCLVC1104	1	2	3, 8, 5, 7	6	4
CDCLVC1106	1	2	3, 14, 11, 13, 6, 9	5, 8, 12	4, 7, 10
CDCLVC1108	1	2	3, 16, 13, 15, 6, 11, 8, 9	5, 10, 14	4, 7, 12
CDCLVC1110	1	2	3, 20, 17, 19, 6, 15, 8, 13, 10	5, 9, 14, 18	4, 7, 11, 16
CDCLVC1112	1	2	3, 24, 21, 23, 6, 19, 8, 17, 16, 10, 14, 12	5, 9, 13, 18, 22	4, 7, 11, 15, 20

### **OUTPUT LOGIC TABLE**

INP	UTS	OUTPUTS
CLKIN	1G	Yn
X	L	L
L	Н	L
Н	Н	Н



## **ABSOLUTE MAXIMUM RATINGS**(1)

over operating free-air temperature range (unless otherwise noted)

		VALUE / UNIT
$V_{DD}$	Supply voltage range	–0.5 V to 4.6 V
V <sub>IN</sub>	Input voltage range (2)	-0.5 V to V <sub>DD</sub> + 0.5 V
Vo	Output voltage range (2)	-0.5 V to V <sub>DD</sub> + 0.5 V
I <sub>IN</sub>	Input current	±20 mA
Io	Continuous output current	±50 mA
TJ	Maximum junction temperature	125°C
T <sub>ST</sub>	Storage temperature range	−65°C to 150°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### THERMAL INFORMATION

		DCDLVC1102/03/04	CDCLVC1106	CDCLVC1108	CDCLVC11010	CDCLVC1112	
	THERMAL METRIC <sup>(1)</sup>	PW	PW	PW	PW	PW	UNITS
		8 PINS	14 PINS	16 PINS	20 PINS	24 PINS	
$\theta_{JA}$	Junction-to-ambient thermal resistance (2)	149.4	112.6	108.4	83.0	87.9	°C/W
$\theta_{JC(top)}$	Junction-to-case(top) thermal resistance (3)	69.4	48.0	33.6	32.3	26.5	·C/VV

- (1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.
- (2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.
- (3) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC-standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

#### RECOMMENDED OPERATING CONDITIONS

over operating free-air temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT	
V	Complete state and state and	3.3 V supply	3.0	3.3	3.6	\/	
$V_{DD}$	Supply voltage range	2.5 V supply	2.3	2.5	2.7	V	
V	Low lovel input voltage	V <sub>DD</sub> = 3.0 V to 3.6 V			V <sub>DD</sub> /2 - 600	m\/	
$V_{IL}$	Low-level input voltage	$V_{DD} = 2.3 \text{ V to } 2.7 \text{ V}$			$V_{DD}/2 - 400$	mV	
V	Lligh lovel input voltage	V <sub>DD</sub> = 3.0 V to 3.6 V	V <sub>DD</sub> /2 + 600			mV	
$V_{IH}$	High-level input voltage	$V_{DD} = 2.3 \text{ V to } 2.7 \text{ V}$	V <sub>DD</sub> /2 + 400	V <sub>DD</sub> /2 + 400			
$V_{th}$	Input threshold voltage	V <sub>DD</sub> = 2.3 V to 3.6 V		V <sub>DD</sub> /2		mV	
$t_r / t_f$	Input slew rate		1		4	V/ns	
	Minimum pulse width at	V <sub>DD</sub> = 3.0 V to 3.6 V	1.8			no	
t <sub>w</sub>	CLKIN	V <sub>DD</sub> = 2.3 V to 2.7 V	2.75			ns	
£	LVCMOS clock Input	$V_{DD} = 3.0 \text{ V to } 3.6 \text{ V}$	DC		250	MHz	
f <sub>CLK</sub>	Frequency	V <sub>DD</sub> = 2.3 V to 2.7 V	DC		180	IVI⊓Z	
T <sub>A</sub>	Operating free-air tempera	ture	-40		85	°C	

<sup>(2)</sup> This value is limited to 4.6 V maximum.

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### **DEVICE CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	CONDITION	MIN	TYP <sup>(1)</sup>	MAX	UNIT
OVEF	RALL PARAMETERS FOR ALL V	/ERSIONS	•			
	Ctatic device assument(2)	$1G = V_{DD}$ ; CLKIN = 0 V or $V_{DD}$ ; $I_O = 0$ mA; $V_{DD} = 3.6$ V		6	10	mA
I <sub>DD</sub>	Static device current <sup>(2)</sup>	$1G = V_{DD}$ ; CLKIN = 0 V or $V_{DD}$ ; $I_{O} = 0$ mA; $V_{DD} = 2.7$ V 3				
I <sub>PD</sub>	Power down current	$1G = 0 \text{ V}$ ; CLKIN = 0 V or $V_{DD}$ ; $I_{O} = 0 \text{ mA}$ ; $V_{DD} = 3.6 \text{ V}$ or 2.7 V			60	μΑ
<u> </u>	Power dissipation capacitance	V <sub>DD</sub> = 3.3 V; f = 10 MHz		6		pF
C <sub>PD</sub>	per output <sup>(3)</sup>	$V_{DD} = 2.5 \text{ V}; f = 10 \text{ MHz}$		4.5		pF
	Input leakage current at 1G	V 0V mV V 00V m 0.7V			± 8	^
I <sub>I</sub>	Input leakage current at CLKIN	$V_{I} = 0 \text{ V or } V_{DD}, V_{DD} = 3.6 \text{ V or } 2.7 \text{ V}$			± 25	μΑ
D	Output impadance	V <sub>DD</sub> = 3.3 V		45		Ω
R <sub>OUT</sub>	Output impedance	V <sub>DD</sub> = 2.5 V		60		Ω
£	Output fraguancy	$V_{DD} = 3.0 \text{ V to } 3.6 \text{ V}$	DC		250	MHz
f <sub>OUT</sub>	Output frequency	V <sub>DD</sub> = 2.3 V to 2.7 V	DC		180	MHz
OUTF	PUT PARAMETERS FOR $V_{DD} = 3$	3.3 V ± 0.3 V				
		$V_{DD} = 3 \text{ V}, I_{OH} = -0.1 \text{ mA}$	2.9			
$V_{OH}$	High-level output voltage	$V_{DD} = 3 \text{ V, } I_{OH} = -8 \text{ mA}$	2.5			V
		$V_{DD} = 3 \text{ V}, I_{OH} = -12 \text{ mA}$	2.2			
		$V_{DD} = 3 \text{ V}, I_{OL} = 0.1 \text{ mA}$			0.1	
$V_{OL}$	Low-level output voltage	V <sub>DD</sub> = 3 V, I <sub>OL</sub> = 8 mA			0.5	V
		V <sub>DD</sub> = 3 V, I <sub>OL</sub> = 12 mA			8.0	
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation delay	CLKIN to Yn	0.8		2.0	ns
t <sub>sk(o)</sub>	Output skew	Equal load of each output			50	ps
t <sub>r</sub> /t <sub>f</sub>	Rise and fall time	20%–80% (V <sub>OH</sub> - V <sub>OL</sub> )	0.3		8.0	ns
t <sub>DIS</sub>	Output disable time	1G to Yn			6	ns
t <sub>EN</sub>	Output enable time	1G to Yn			6	ns
t <sub>sk(p)</sub>	Pulse skew ; t <sub>PLH(Yn)</sub> - t <sub>PHL(Yn)</sub> (4)	To be measured with input duty cycle of 50%			180	ps
t <sub>sk(pp)</sub>	Part-to-part skew	Under equal operating conditions for two parts			0.5	ns
t <sub>jitter</sub>	Additive jitter rms	12kHz20 MHz, f <sub>OUT</sub> = 250 MHz			100	fs

<sup>(1)</sup> All typical values are at respective nominal  $V_{DD}$ . For switching characteristics, outputs are terminated to 50  $\Omega$  to  $V_{DD}/2$  (see Figure 1).

For dynamic  $I_{DD}$  over frequency see Figure 8 and Figure 9.

This is the formula for the power dissipation calculation (see Figure 8 and the Power Consideration section).  $P_{tot} = P_{stat} + P_{dyn} + P_{Cload} [W]$   $P_{stat} = V_{DD} \times I_{DD} [W]$   $P_{dyn} = C_{PD} \times V_{DD} \times f [W]$   $P_{Cload} = C_{load} \times V_{DD} \times f [W]$  n = Number of switching output pins  $total depends on output rises and fall-time (t/t). The output duty-cycle can be calculated; odc = (t_{load} + t_{load} + t_{load}$ 

 $t_{sk(p)}$  depends on output rise- and fall-time  $(t_r/t_f)$ . The output duty-cycle can be calculated: odc =  $(t_{w(OUT)} \pm t_{sk(p)})/t_{period}$ ;  $t_{w(OUT)}$  is pulse-width of output waveform and tperiod is  $1/f_{OUT}$ .



## **DEVICE CHARACTERISTICS (continued)**

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	CONDITION	MIN TYP(1)	MAX	UNIT
OUTP	PUT PARAMETERS FOR V <sub>DD</sub> =	2.5 V ± 0.2 V			
\/	Lligh lovel output voltage	$V_{DD} = 2.3 \text{ V}, I_{OH} = -0.1 \text{ mA}$	2.2		V
V <sub>OH</sub>	High-level output voltage	$V_{DD} = 2.3 \text{ V}, I_{OH} = -8 \text{ mA}$	1.7		V
\/	Low level output voltage	$V_{DD} = 2.3 \text{ V}, I_{OL} = 0.1 \text{ mA}$		0.1	V
V <sub>OL</sub>	Low-level output voltage	$V_{DD} = 2.3 \text{ V}, I_{OL} = 8 \text{ mA}$		0.5	V
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation delay	CLKIN to Yn	1.0	2.6	ns
t <sub>sk(o)</sub>	Output skew	Equal load of each output		50	ps
t <sub>r</sub> /t <sub>f</sub>	Rise and fall time	20%–80% reference point	0.3	1.2	ns
$t_{DIS}$	Output disable time	1G to Yn		10	ns
$t_{EN}$	Output enable time	1G to Yn		10	ns
t <sub>sk(p)</sub>	Pulse skew ; t <sub>PLH(Yn)</sub> - t <sub>PHL(Yn)</sub> (5)	To be measured with input duty cycle of 50%		220	ps
t <sub>sk(pp)</sub>	Part-to-part skew	Under equal operating conditions for two parts		1.2	ns
t <sub>jitter</sub>	Additive jitter rms	12kHz20 MHz, f <sub>OUT</sub> = 180 MHz		350	fs

<sup>(5)</sup>  $t_{sk(p)}$  depends on output rise- and fall-time  $(t_r/t_f)$ . The output duty-cycle can be calculated: odc =  $(t_{w(OUT)} \pm t_{sk(p)})/t_{period}$ ;  $t_{w(OUT)}$  is pulse-width of output waveform and tperiod is  $1/f_{OUT}$ .



#### PARAMETERS MEASUREMENT INFORMATION

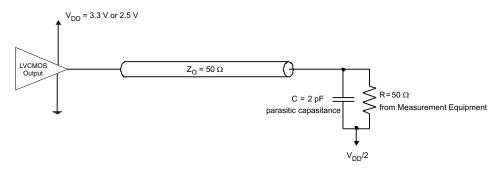


Figure 1. Test Load Circuit

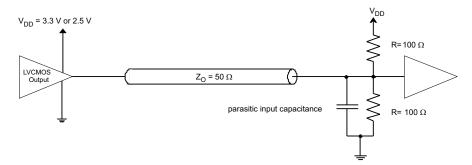


Figure 2. Application Load With 50  $\Omega$  Line Termination

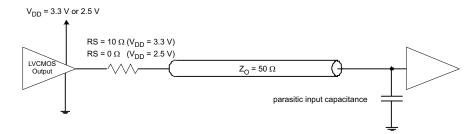
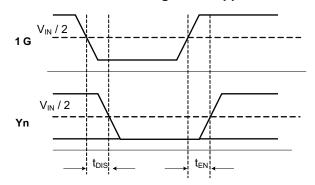
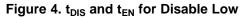


Figure 3. Application Load With Series Line Termination





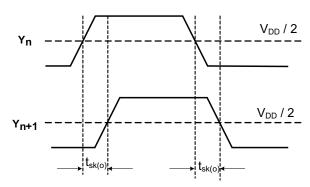


Figure 5. Output Skew  $t_{sk(o)}$ 

## PARAMETERS MEASUREMENT INFORMATION (continued)

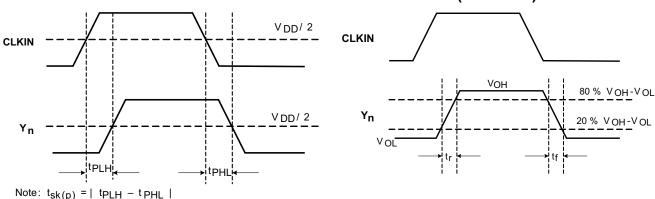


Figure 6. Pulse Skew  $t_{sk(p)}$  and Propagation Delay  $t_{PLH}/t_{PHL}$ 

Figure 7. Rise/Fall Times t<sub>r</sub>/t<sub>f</sub>

#### TYPICAL CHARACTERISTICS

#### **Power Consideration**

The following power consideration refers to the device-consumed power consumption only. The device power consumption is the sum of static power and dynamic power. The dynamic power usage consists of two components:

- 1. Power used by the device as it switches states.
- 2. Power required to charge any output load.

The output load can be capacitive only or capacitive and resistive. The following formula and the power graphs in Figure 8 and Figure 9 can be used to obtain the power consumption of the device:

$$\begin{aligned} &P_{dev} = P_{stat} + n \; (P_{dyn} + P_{Cload}) \\ &P_{stat} = V_{DD} \; x \; I_{DD} \\ &P_{dyn} + P_{Cload} = see \; Figure \; 8 \; and \; Figure \; 9 \end{aligned}$$

where:

 $V_{DD}$  = Supply voltage (3.3 V or 2.5 V)  $I_{DD}$  = Static device current (typ 6 mA for  $V_{DD}$  = 3.3 V; typ 3 mA for  $V_{DD}$  = 2.5 V)  $I_{DD}$  = Number of switching output pins

Example for Device Power Consumption for CDCLVC1104: 4 outputs are switching, f = 120 MHz,  $V_{DD}$  = 3.3 V and  $C_{load}$  = 2 pF per output:

$$P_{dev} = P_{stat} + n (P_{dyn} + P_{Cload}) = 19.8 \text{ mW} + 40 \text{ mW} = 59.8 \text{ mW}$$
  
 $P_{stat} = V_{DD} \times I_{DD} = 6 \text{ mA} \times 3.3 \text{ V} = 19.8 \text{ mW}$   
 $n (P_{dyn} + P_{Cload}) = 4 \times 10 \text{ mW} = 40 \text{ mW}$ 

#### **NOTE**

For dimensioning the power supply, the total power consumption needs to be considered. The total power consumption is the sum of the device power consumption and the power consumption of the load.



# TEXAS INSTRUMENTS

## **TYPICAL CHARACTERISTICS (continued)**

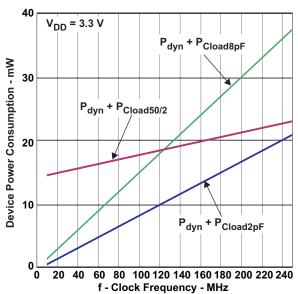


Figure 8. Device Power Consumption vs Clock Frequency (Load  $50\Omega$  into  $V_{DD}/2$ . 2pF, 8pF; Per Output)

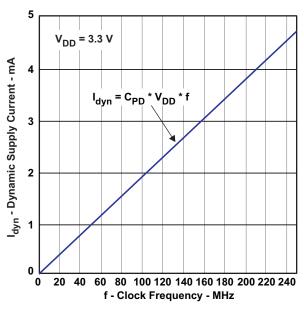


Figure 10. Dynamic Supply Current vs Clock Frequency  $(C_{PD} = 6pF, No Load; Per Output)$ 

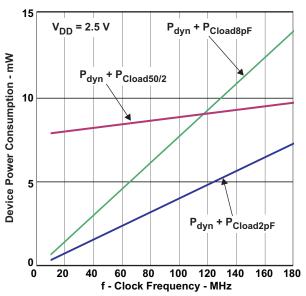


Figure 9. Device Power Consumption vs Clock Frequency (Load  $50\Omega$  into  $V_{DD}/2$ . 2pF, 8pF; Per Output)

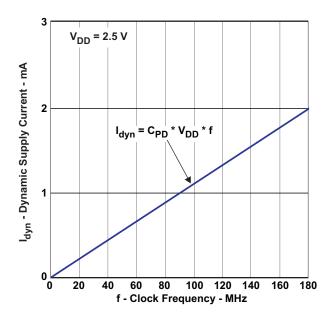


Figure 11. Dynamic Supply Current vs Clock Frequency (C<sub>PD</sub> = 4.5pF, No Load; Per Output)



26-Jun-2010

#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/ Ball Finish	MSL Peak Temp <sup>(3)</sup>	Samples (Requires Login)
CDCLVC1102PW	ACTIVE	TSSOP	PW	8	150	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
CDCLVC1102PWR	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
CDCLVC1103PW	ACTIVE	TSSOP	PW	8	150	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
CDCLVC1103PWR	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Samples
CDCLVC1104PW	ACTIVE	TSSOP	PW	8	150	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
CDCLVC1104PWR	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Samples
CDCLVC1106PW	ACTIVE	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
CDCLVC1106PWR	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Samples
CDCLVC1108PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
CDCLVC1108PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Samples
CDCLVC1110PW	ACTIVE	TSSOP	PW	20	70	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
CDCLVC1110PWR	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Samples
CDCLVC1112PW	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Purchase Samples
CDCLVC1112PWR	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.



## PACKAGE OPTION ADDENDUM

26-Jun-2010

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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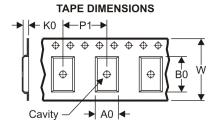
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## **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



\*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCLVC1102PWR	TSSOP	PW	8	2000	330.0	12.4	7.0	3.6	1.6	8.0	12.0	Q1
CDCLVC1103PWR	TSSOP	PW	8	2000	330.0	12.4	7.0	3.6	1.6	8.0	12.0	Q1
CDCLVC1104PWR	TSSOP	PW	8	2000	330.0	12.4	7.0	3.6	1.6	8.0	12.0	Q1
CDCLVC1106PWR	TSSOP	PW	14	2000	330.0	12.4	7.0	5.6	1.6	8.0	12.0	Q1
CDCLVC1108PWR	TSSOP	PW	16	2000	330.0	12.4	7.0	5.6	1.6	8.0	12.0	Q1
CDCLVC1110PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
CDCLVC1112PWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDCLVC1102PWR	TSSOP	PW	8	2000	346.0	346.0	29.0
CDCLVC1103PWR	TSSOP	PW	8	2000	346.0	346.0	29.0
CDCLVC1104PWR	TSSOP	PW	8	2000	346.0	346.0	29.0
CDCLVC1106PWR	TSSOP	PW	14	2000	346.0	346.0	29.0
CDCLVC1108PWR	TSSOP	PW	16	2000	346.0	346.0	29.0
CDCLVC1110PWR	TSSOP	PW	20	2000	346.0	346.0	33.0
CDCLVC1112PWR	TSSOP	PW	24	2000	346.0	346.0	33.0

## PW (R-PDSO-G\*\*)

#### 14 PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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